Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/607,338	NISHIZAWA, SHIN
Examiner	Art Unit

Daquan Zhao

2621

SEARCHED					
Class	Subclass	Date	Examiner		
386	125-126	4/9/2007	DZ		
347	225	4/9/2007	DZ		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	·EXMR
USPAT; USPGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB (see search note attached)	4/9/2007	DZ
see search note for inventor name search	4/9/2007	DZ
consult with Nguyen Huy for searching	4/9/2007	DZ